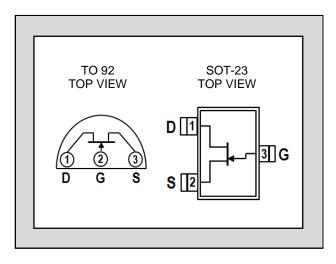


Over 30 Years of Quality Through Innovation

| FEATURES | | | | |
|---|--|--|--|--|
| ULTRA LOW NOISE | $e_n = 1.8 \text{nV}/\sqrt{\text{Hz}}$ | | | |
| LOW INPUT CAPACITANCE | C _{ISS} = 4pF | | | |
| ABSOLUTE MAXIMUM RATINGS¹ @ 25 °C (unless otherwise stated) | | | | |
| Maximum Temperatures | | | | |
| Storage Temperature | -55 to +150°C | | | |
| Junction Operating Temperature | -55 to +150°C | | | |
| Maximum Power Dissipation | | | | |
| Continuous Power Dissipation TA=25°C | 300mW ⁴ | | | |
| Maximum Currents | | | | |
| Gate Forward Current | $I_{G(F)} = 10mA$ | | | |
| Maximum Voltages | | | | |
| Gate to Source | V _{GSO} = 60V | | | |
| Gate to Drain | V _{GDO} = 60V | | | |

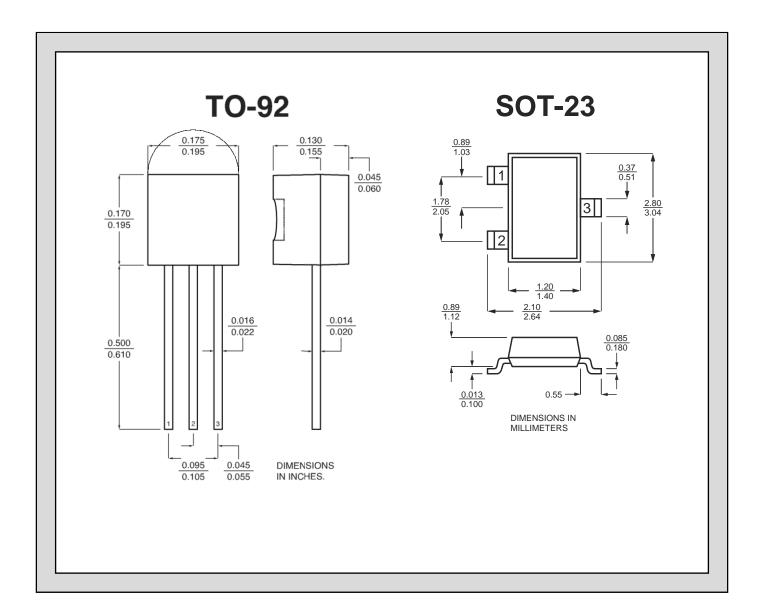
LSK189

LOW NOISE, LOW CAPACITANCE SINGLE N-CHANNEL JFET



^{*} For equivalent monolithic dual, see LSK489

| SYMBOL | CHARACTERISTIC | MIN | TYP | MAX | UNITS | CONDITIONS | |
|-------------------------------|-------------------------------------|------|------|------|--------|---|--|
| BV _{GSS} | Gate to Source Breakdown Voltage | -60 | | | V | $V_{DS} = 0$, $I_D = -1nA$ | |
| $V_{GS(OFF)}$ | Gate to Source Pinch-off Voltage | -1.5 | | -3.5 | V | $V_{DS} = 15V, I_{D} = 1nA$ | |
| V _G s | Gate to Source Operating Voltage | -0.5 | | -3.5 | V | $V_{DS} = 15V, I_{D} = 500\mu A$ | |
| l _{DSS} ² | Drain to Source Saturation Current | 2.5 | 5 | 15 | mA | $V_{DS} = 15V, V_{GS} = 0$ | |
| lg | Coto Operating Current | | -2 | -25 | рА | V _{DG} = 15V, I _D = 200μA TA=125°C | |
| lg | Gate Operating Current | | -0.8 | -10 | nA | | |
| I _{GSS} | Gate to Source Leakage Current | | | -100 | pА | $V_{GS} = -15V$ | |
| G _{fs} | Full Conductance Transconductance | 1500 | | | μS | $V_{DS} = 15V$, $V_{GS} = 0$, $f = 1kHz$ | |
| Gfs | | 1000 | 1500 | | μS | $V_{DS} = 15V, I_{D} = 500\mu A$ | |
| Gos | Full Output Conductance | | | 40 | μS | $V_{DS} = 15V, V_{GS} = 0$ | |
| Gos | Output Conductance | | 1.8 | 2.7 | μS | $V_{DS} = 15V, I_{D} = 200\mu A$ | |
| NF | Noise Figure | | | 0.5 | dB | $V_{DS} = 15V$, $V_{GS} = 0$, $R_{G} = 10M\Omega$, $f = 100Hz$, $NBW = 6Hz$ | |
| en | Noise Voltage | | 1.8 | 2.0 | nV/√Hz | $V_{DS} = 15V$, $I_D = 2mA$, $f = 1kHz$, $NBW = 1Hz$ | |
| e n | Noise Voltage | | 2.8 | 3.5 | nV/√Hz | $V_{DS} = 15V$, $I_{D} = 2mA$, $f = 10Hz$, $NBW = 1Hz$ | |
| C _{ISS} | Common Source Input Capacitance | | 4 | 8 | pF | \\ 45\\ \- 500\\\ \\ 1 \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \ | |
| Crss | Common Source Reverse Transfer Cap. | | | 3 | pF | $V_{DS} = 15V$, $I_{D} = 500\mu A$, $f = 1MHz$ | |

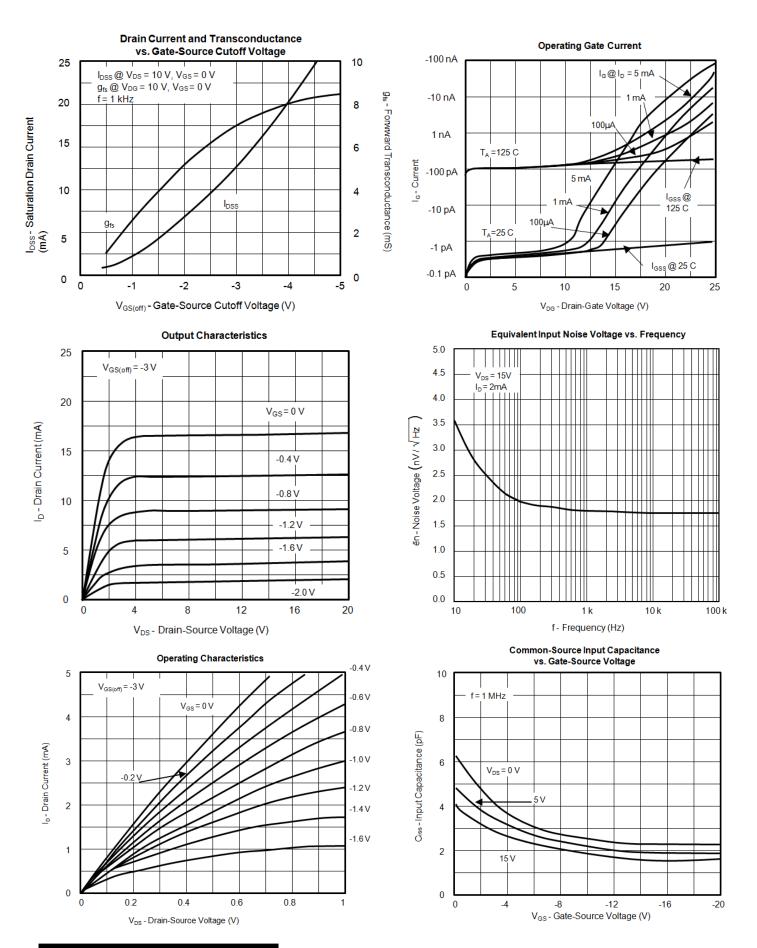


NOTES:

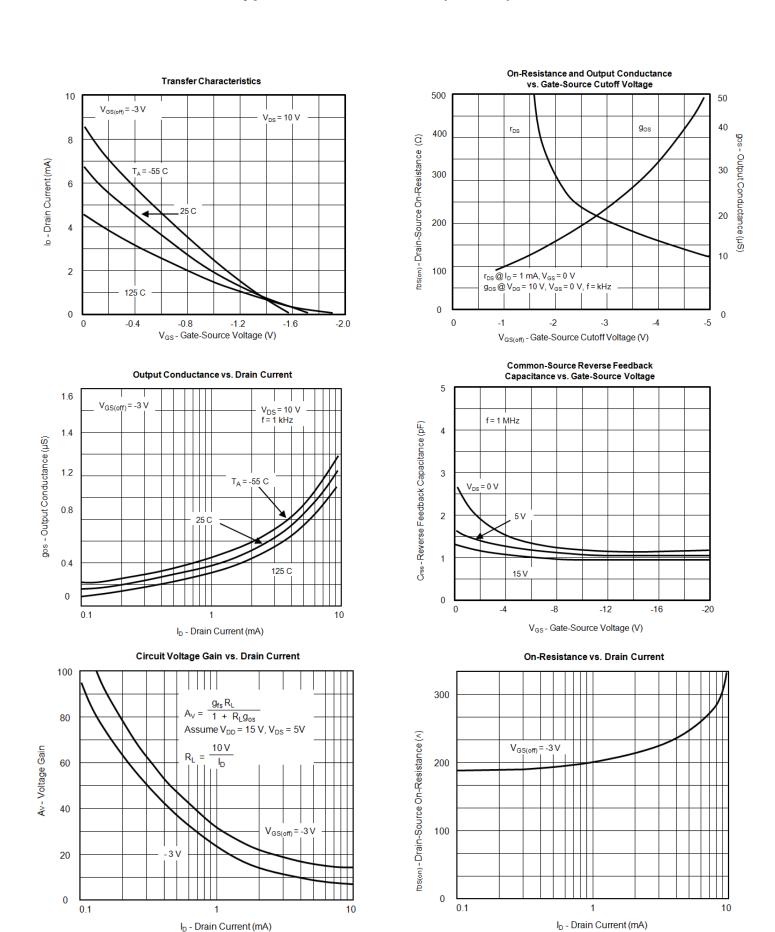
- 1. Absolute maximum ratings are limiting values above which serviceability may be impaired.
- 2. Pulse Test: PW ≤ 300µs, Duty Cycle ≤ 3%.
- 3. All characteristics MIN/TYP/MAX numbers are absolute values. Negative values indicate electrical polarity only.
- 4. Derate 2.8 mW °C above 25°C.

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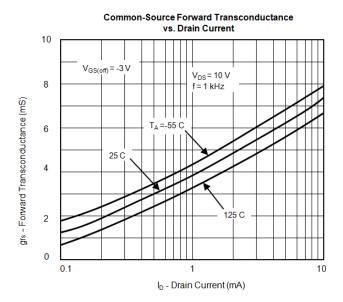
Typical Characteristics



Typical Characteristics (Cont'd)



Typical Characteristics (Cont'd)



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